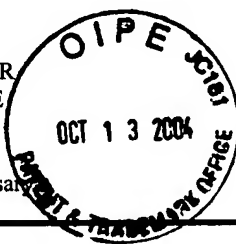


LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

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FOREIGN PATENT DOCUMENTS

FOREIGN TRAVEL DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AY	201205	12/1986	Europe				
	AZ	1-209380	8/23/1989	Japan				
	BA	2-220453	9/1990	Japan				

PTO/SB/08A LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)	ATTY. DOCKET NO. JEV/KAR:1016.2019	SERIAL NO.
	APPLICANT Randy J. Schwindt et al.	
	FILING DATE Herewith	GROUP

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	BB		Micromanipulator Company, Inc., "Test Station Accessories." (1983)
	BC		Micromanipulator Company, Inc., "Model 8000 Test Station." (1986)
	BD		"Model TPO3000 Series Thermochuck® Systems," four-page product note, Temptronic Corporation, Newton, MA (May 1992 or earlier)
	BE		
	BF		"Application Note 1 Controlled Environment Enclosure," two-page application note, Temptronic Corporation, Newton, MA (May 1992 or earlier)
	BG		Micromanipulator Company, Inc. "Model 8000 Test Station." (1988)
	BH		Applebay, Harry F. Deposition transcript (pp. 61-67) with exhibits 581 A.B.C. describing Flexion AP-1 probe station sold in 1987 (May 1988)
	BI		"Cross Section Signatone S-1240," one-page sketch prepared by Signatone counsel.
	BJ		"S-1240," two-page product note, Signatone, San Jose, CA (February 1988 or earlier per Signatone counsel)
	BK		Y. Yamamoto, "A Compact Self-Shielding Prober . . ." IEEE Trans., Inst. and Meas., Vol. 38, pp. 1088-1093 (1989)
	BL		Temptronic's "Guarded" Chuck, one-page note describing guarding system of Temptronic Corporation of Newton, MA, dated 11/15/89.
	BM		Beck & Tomann, "Chip Tester," IBM Technical Disclosure Bulletin, p. 4819 (January 1985).
	BN		Article by William Knauer entitled "Fixturing for Low-Current/Low Voltage Parametric Testing," appearing in Evaluation Engineering, (1990), pp. 150-153
	BO		Hewlett-Packard, "Application Note 356-HP 4142B Modular DC Source/Monitor Practical Application," (Nov. 1987), pp. 1-4
	BP		Hewlett-Packard, H-P Model 4284A Precision LCR Meter, Operation Manual (December 1991) pp. 1-2, 6-9 and 6-15
EXAMINER			DATE CONSIDERED
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			